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| VA\13 | AA | 6,100,578 | 08/08/00 | SUZUKI | | | |
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SERIAL NO. ATTY DOCKET NO. DEPARTMENT OF COMMERCE TENT AND TRADEMARK OFFICE Form PTO 1449 206169US99 09/766,046 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamai RAMDANI, et al. FILING DATE **GROUP** 2815 January 19, 2001 **U.S. PATENT DOCUMENTS** FILING DATE **EXAMINER** DOCUMENT SUB DATE NAME CLASS IF APPROPRIATE NUMBER CLASS INITIAL W 2002/0079576 06/27/02 Seshan VX 5,148,504 09/15/92 Levi et al. 2002/0195610 A1 12/26/02 Klosowiak W 12/19/95 Matsuda VZ 5,477,363 Butler et al. 05/18/99 5,905,571 WA WB 5,570,226 10/29/96 Ota 02/11/92 Ishibashi et al. WC 5,087,829 WD 2001/0020278 A1 09/06/01 Saito 6,496,469 B1 12/17/02 Uchizaki WF 5,679,947 10/21/97 Doi et al. 11/01/01 Kadowaki et al. WG 2001/0036142 A1 08/29/95 Yoshida et al. WH 5.446,719 Jiang et al. WI 5,831,960 11/03/98 12/02/97 McKee et al. 5,693,140 WJ WK 6,376,337 B1 04/23/02 Wang et al. 12/04/79 Kroon 4,177,094 WL Makki et al. WM 5,216,359 06/01/93 Nashimoto et al. 10/23/01 WN 6,307,996 B1 Stevens wo 5,371,621 12/05/94 10/10/02 Bojarczuk, Jr et al. WP 2002/0145168 A1 11/02/71 Anderson WQ 3,617,951 WR 5,838,053 11/17/98 Bevan et al. Π . 11/04/97 Wersing et al. WS 5,684,302 5,959,308 Shichijo et al. WT 09/28/99 WU 5,362,972 11/08/94 Yazawa et al. 5,864,171 01/26/99 Yamamoto et al. O ww 5,028,563 07/02/91 Feit et al. WX1 5/937,11/ 08/10/99 Domash **Date Considered** Examiner *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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OF 23 SHEET 2 U.S. DEPARTMENT OF COMMERCE ATTY DOCKET NO. SERIAL NO. Form PTO 1449 PATENT AND TRADEMARK OFFICE (Modified) 206169US99 09/766,046 APPLICANT JAMAL RAMDANI ET AL LIST OF REFERENCES CITED BY APPLICANT FILING DATE GROUP 2815 JANUARY 19, 2001 **U.S. PATENT DOCUMENTS** CLASS SUB FILING DATE DATE **EXAMINER** DOCUMENT NAME IF APPROPRIATE **CLASS** INITIAL NUMBER 10/16/73 Walther 3,766,370 CB 4.006.989 02/08/77 Andringa 08/18/81 Smith et al. CC 4.284.329 4,777,613 10/11/98 Shahan et al. CD 01/31/89 Thornton et al. 4,802,182 CE 11/21/89 4,882,300 Inoue et al. CF 01/23/90 Suzuki CG 4,896,194 03/12/91 4,999,842 Huang et al. CH Cī 5,081,062 01/14/92 Vasudev et al. 10/13/92 Inam-et-al. CJ 5,155,658 09/28/93 CK 5,248,564 Ramesh 11/09/93 CL 5,260,394 Tazaki et al. 12/14/93 ÇМ 5,270,298 Ramesh CN 5,286,985 02/15/94 Taddiken 05/10/94 Oishi et al. $\overline{\mathsf{co}}$ 5,310,707 CP 5,326,721 07/05/94 Summerfelt $\overline{\mathsf{c}\mathsf{a}}$ 5,404,581 04/04/95 Honjo CR 5,418,389 05/23/95 Watanabe 07/25/95 Dijail et al. cs 5,436,759 5,576,879 11/19/96 Nashimoto 5,606,184 02/25/97 Abrokwah, et al. 5,640,267 06/17/97 May et al. 10/07/97 Hayashi et al. 5,674,366 5,729,641 03/17/98 Chandonnet et al. 5,790,583 08/04/98 CZ 5.825.799 10/20/98 Ho et al. 01/05/99 Beranek et al. DΑ 5,857,049 02/23/99 Brunel et al. DB 5.874.860 07/20/99 Ho et al. DC 5,926,496 08/10/99 Abrokwah, et al. DD 5,937,285 5,981,400 11/09/99 DE 11/23/99 Ohba 5,990,495 12/14/99 Corman et al. DG 6,002,375 DH 6,008,762 12/28/99 Nghiem 04/25/00 Koganei et al. 6,055,179 DI 6,107,653 08/22/00 Fitzgerald 09/05/00 Yu et al. ĎΚ 6,113,690 6,114,996 09/05/00 DL Nghiem 09/19/00 DM 6,121,642 Newns 10/03/00 Newns DN 6,128,178 ρQ 6,143,072 11/07/00 McKee et al. DP 6,184,144 02/06/01

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